


<b>Search Notes</b> 	<b>Application/Control No.</b> 10661225	<b>Applicant(s)/Patent Under Reexamination</b> NGUYEN ET AL.
	<b>Examiner</b> Nguyen, Hiep	<b>Art Unit</b> 2816

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
327	175, 18, 20, 26	01-25-07	Hn

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST	01-25-07	Hn

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>